## Applicant(s)/Patent Under Reexamination 10/006,714 PETER ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1714 Tae H Yoon

Application/Control No.

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-5,354,612	10-1994	Miyabayashi, Toshiyuki	428/331
	В	US-2002/0019473 A1	02-2002	KAYSER et al.	524/442
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			.,
	H	US-			
	1	US-			
	J	US-	-		,
	К	US-			
	L'	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name .	Classification
	N				·	
	0					
	Р					
	Q					
	R					
	S					
	Т					

## NON-PATENT DOCUMENTS

	TOTAL POSSIBLITION									
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)								
	U									
	٧									
	w									
	X									

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.